

A Practical Method to Estimate the Spatial Resolution of GEM Detector

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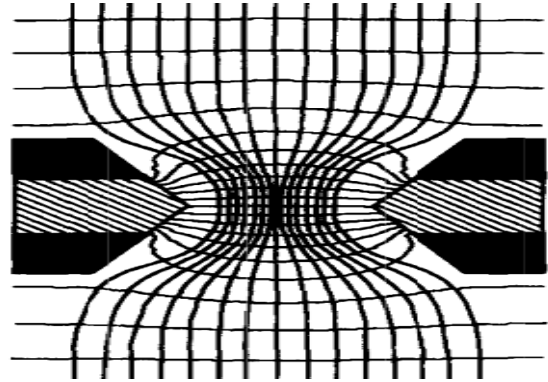
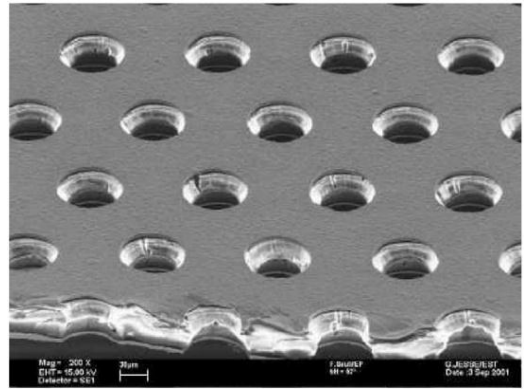
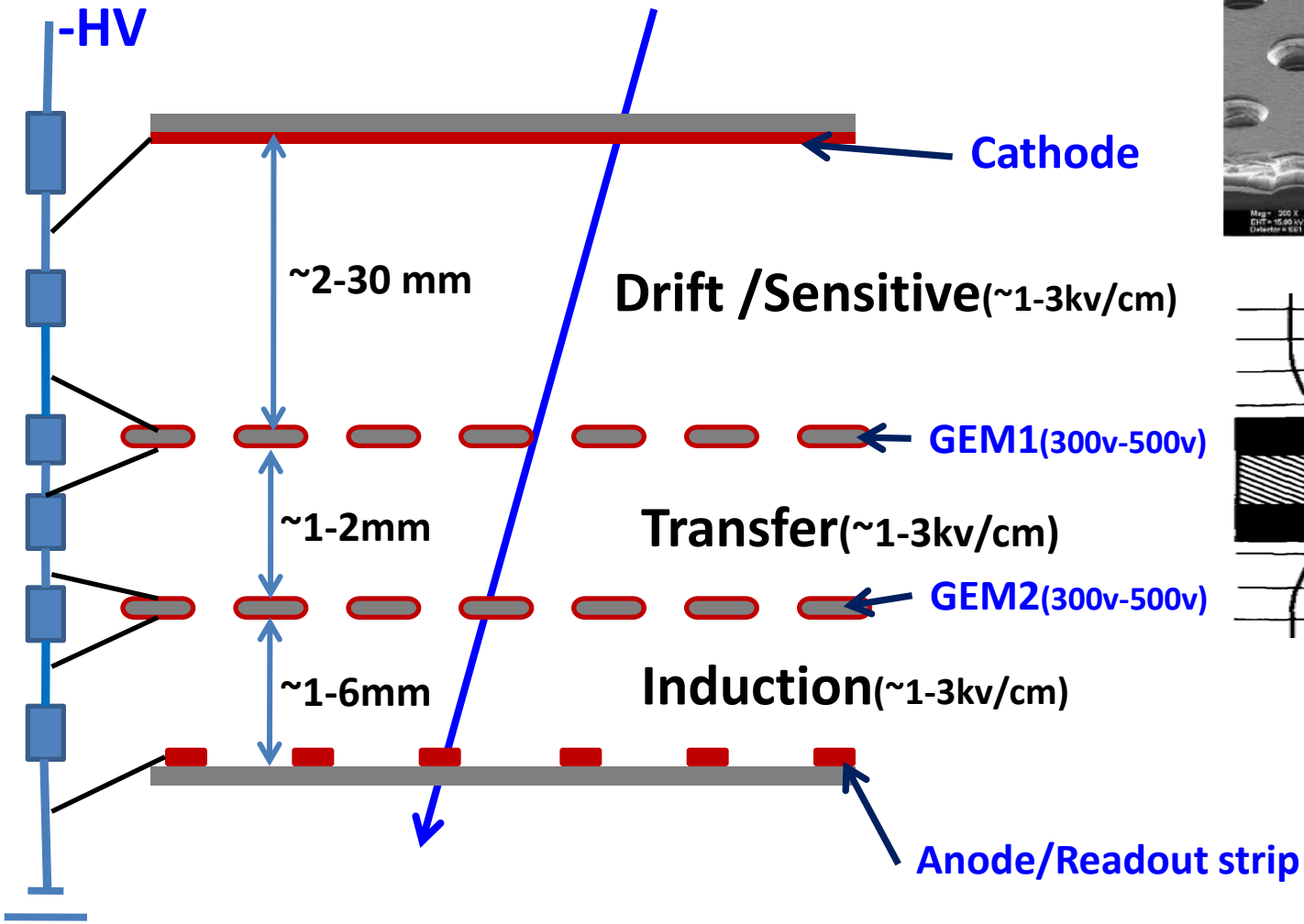
**Collaborators: Yan Huang, Zhi-Gang Xiao, Zhao Zhang
Rong Wang, Haiyan Gao**

**The Fourth Workshop on Hadron Physics in China
and Opportunities with 12GeV JLab**

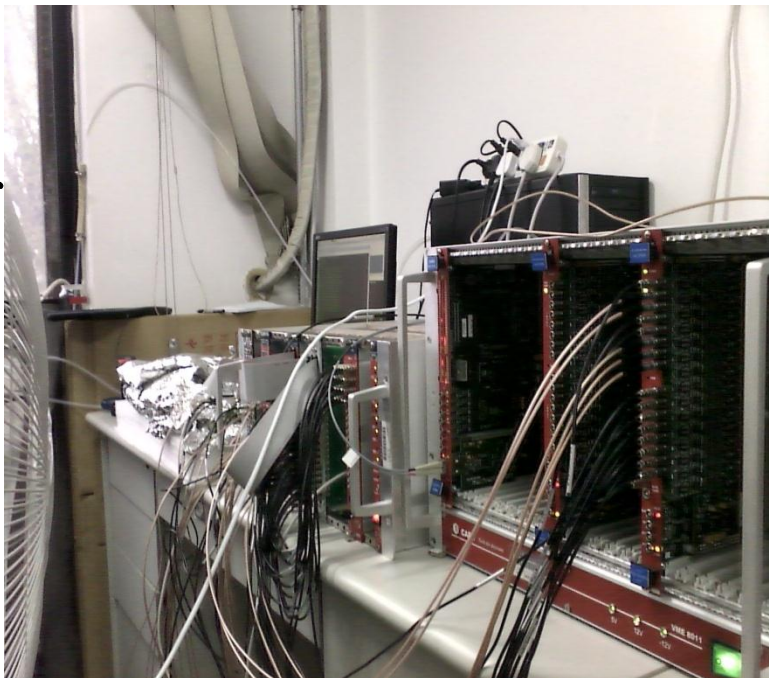
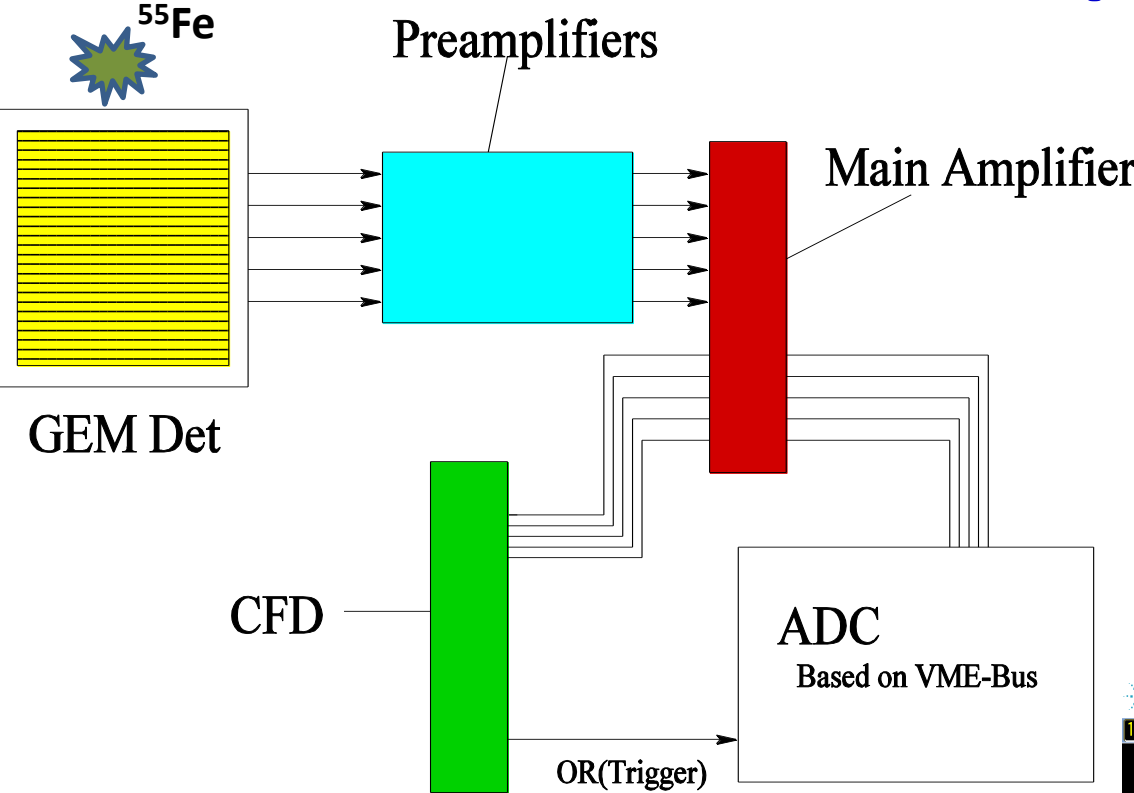
Outline:

- **Introduction**
- **Method description**
- **Experimental results**
- **Near future plans**
- **Summary**

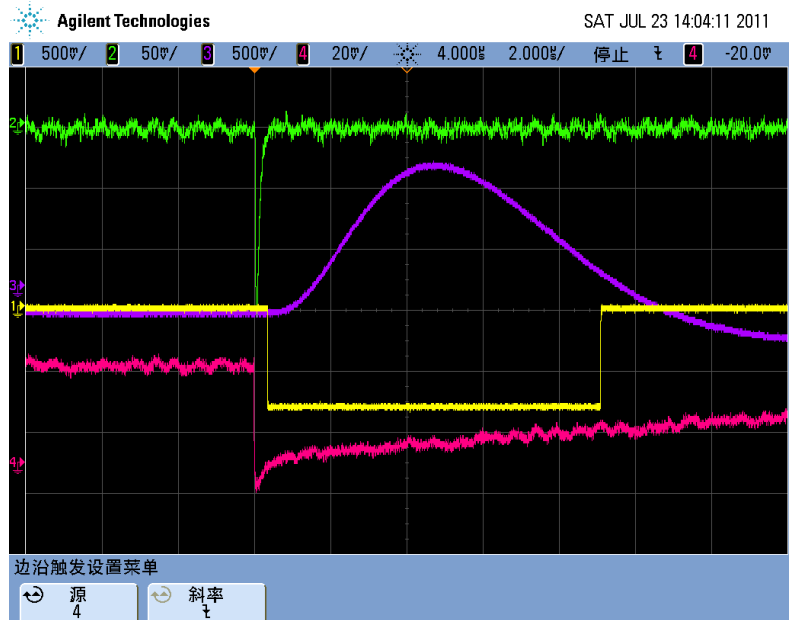
Brief introduction to GEM detector



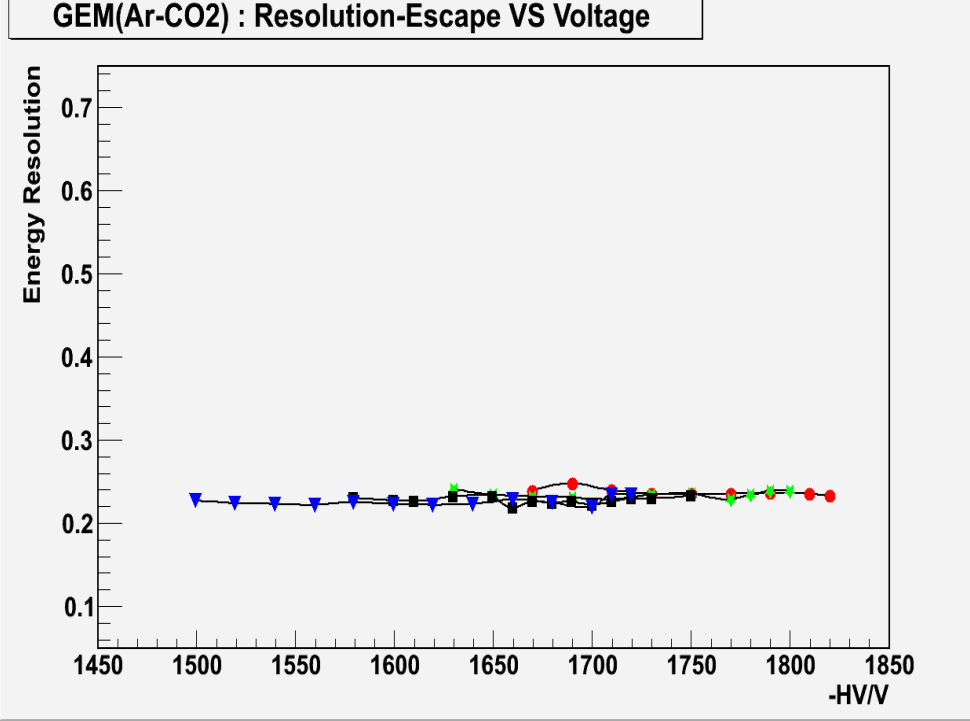
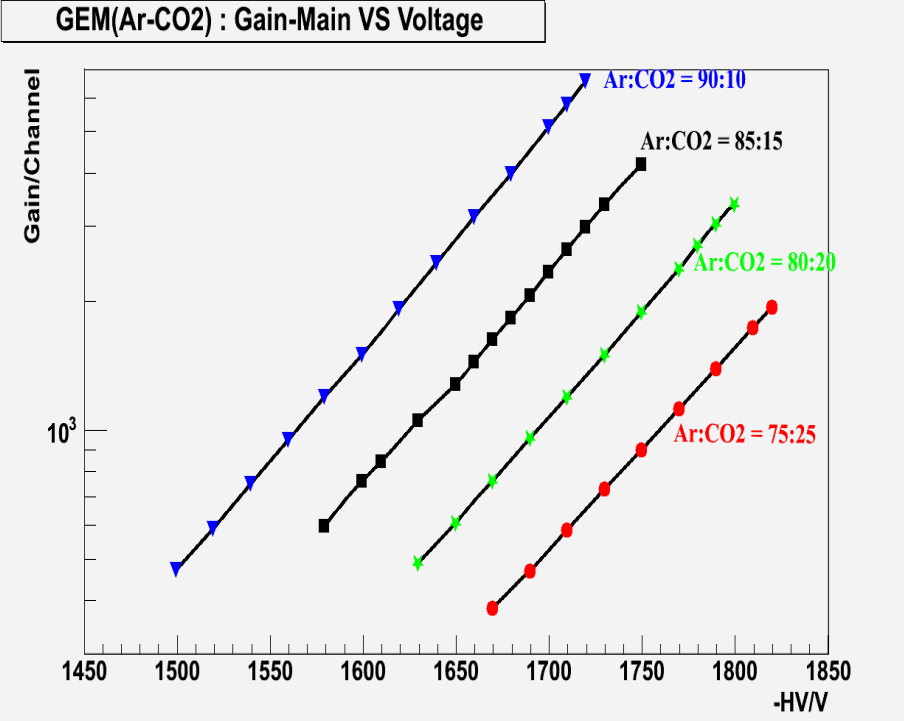
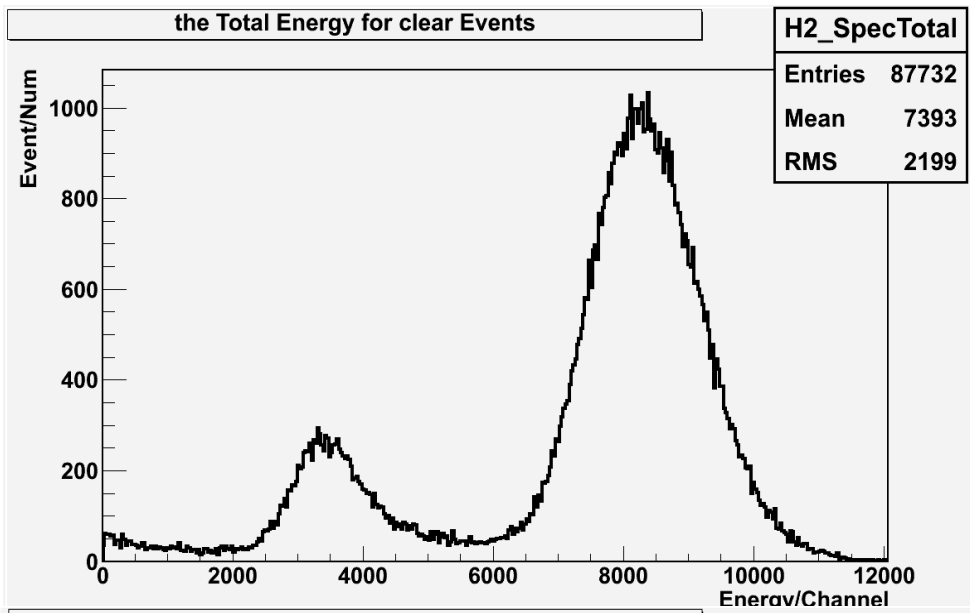
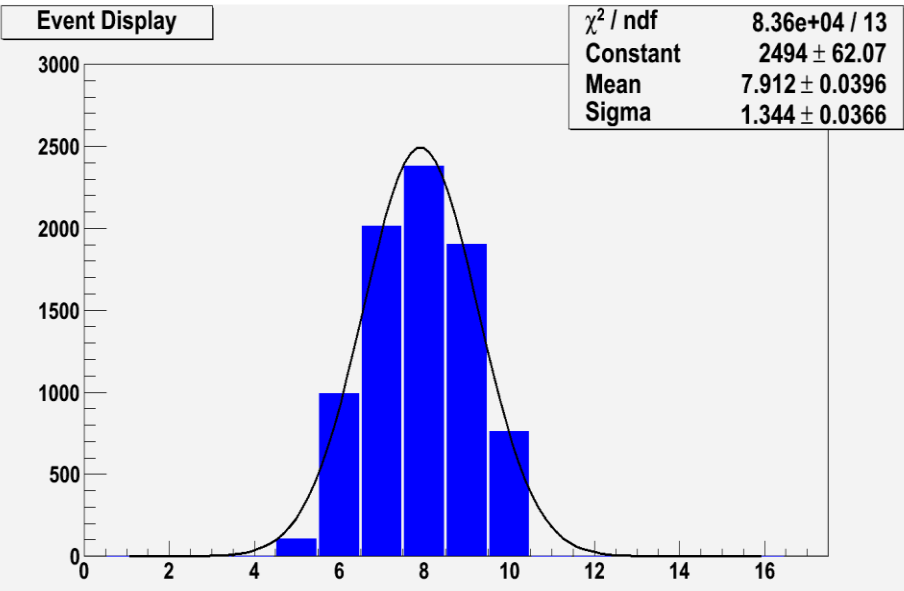
Introduction to the set up



- Readout strip: 1-D, width=200um, 400um;
2-D, width=400um
- Preamplifier: Charge-sensitive, 16 channels
- DAQ: Based on VME-Bus, peak sensitive ADC



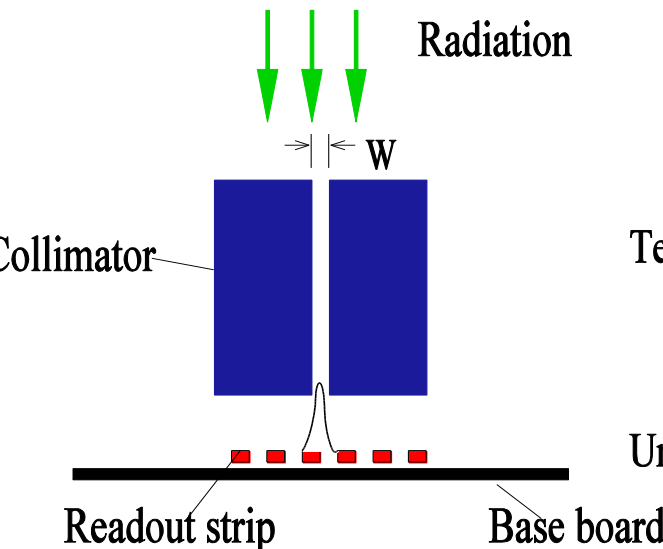
General performance



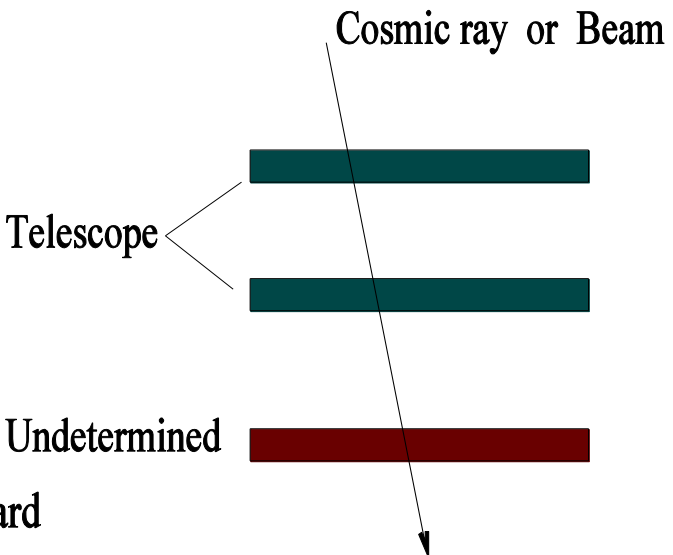
Method description

Conventional methods for spatial resolution

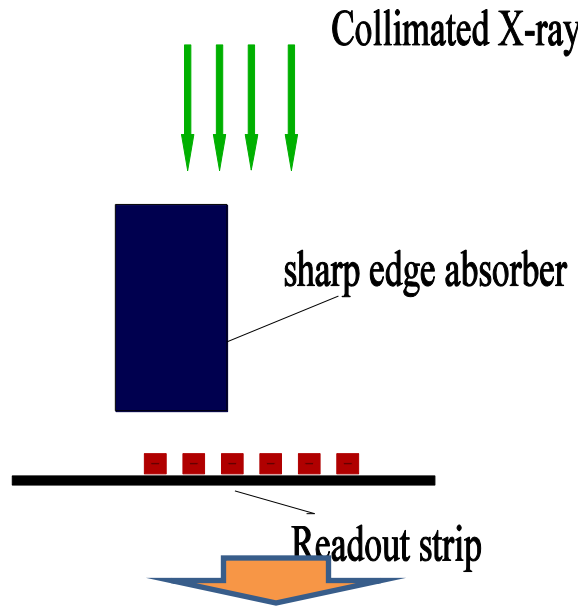
Method I :



Method II :

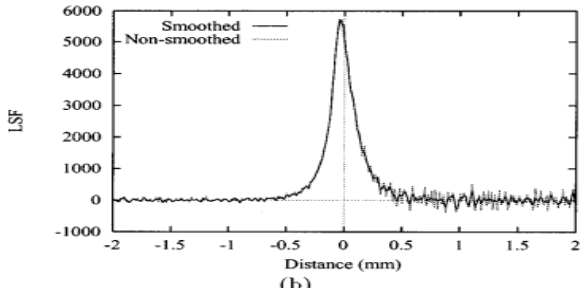
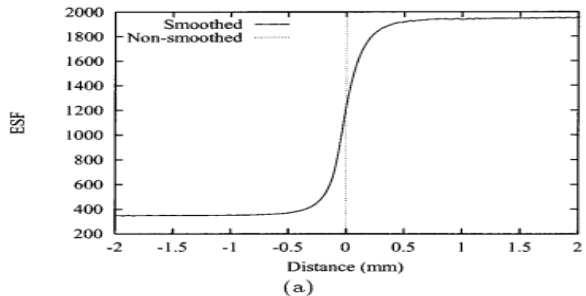


Method III :



Ref:

- 1, RADIOLOGY 93: 257-272, August 1969.
- 2, Med. Phys. 25(1), January 1998
- 3, Med. Phys. 11(6), 1984



Comparison of different methods

#Method	$\sigma_0 / \mu\text{m}$
Method 1 (slit width=200 μm) No deconvolution	1314.9
Method 1 (slit width=200 μm) With deconvolution	65.0
Method 1 (slit width $\sim 10\mu\text{m}$)	59.9
Method 3	71.3
Method 3 (with improved data processing)	63.3

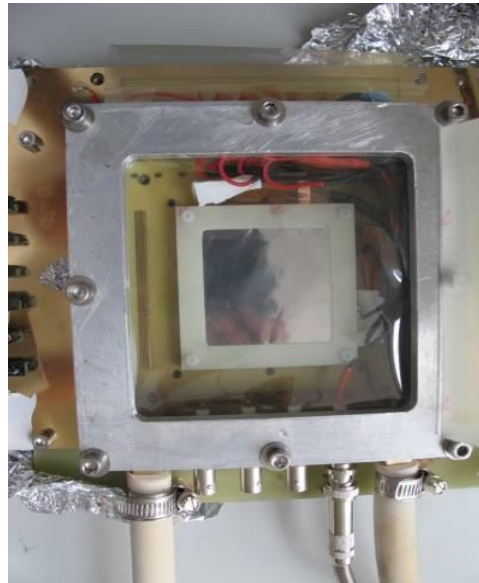
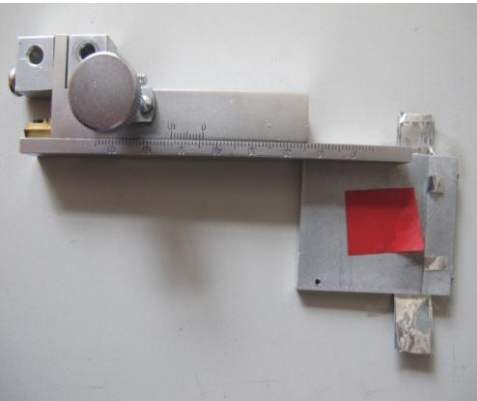
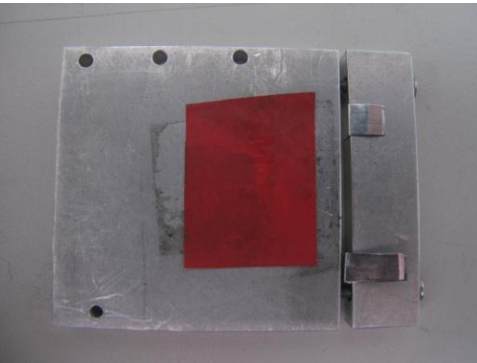
Ref: Chinese Physics C, Vol. 36, No. 3, Page 228-234

Difficulties:

- ◆ Method 1: Precise slit fabrication and alignment in the radiation;
or intense radioactive source;
- ◆ Method 2: Complex auxiliary equipment;
- ◆ Method 3: Precise edge fabrication and collimated X-ray source needed;

But, what we have:

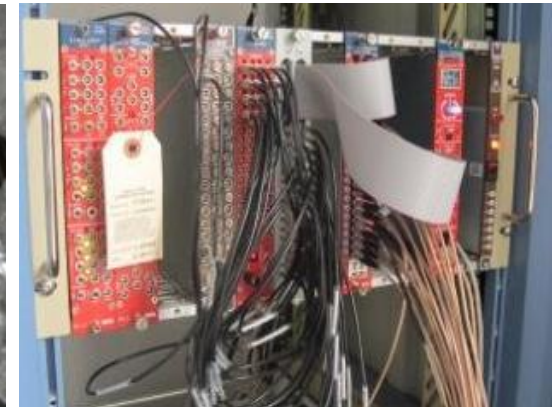
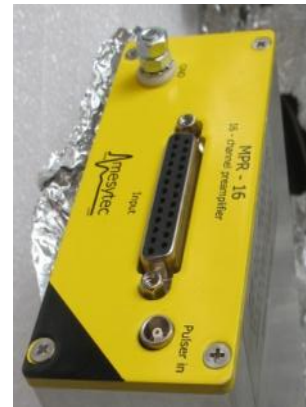
1, A slit with adjustable width, but the width can NOT be measured precisely.



2, a ^{55}Fe with low Activity (5×10^4 Bq), Surface source, $s \sim 0.78\text{cm}^2$

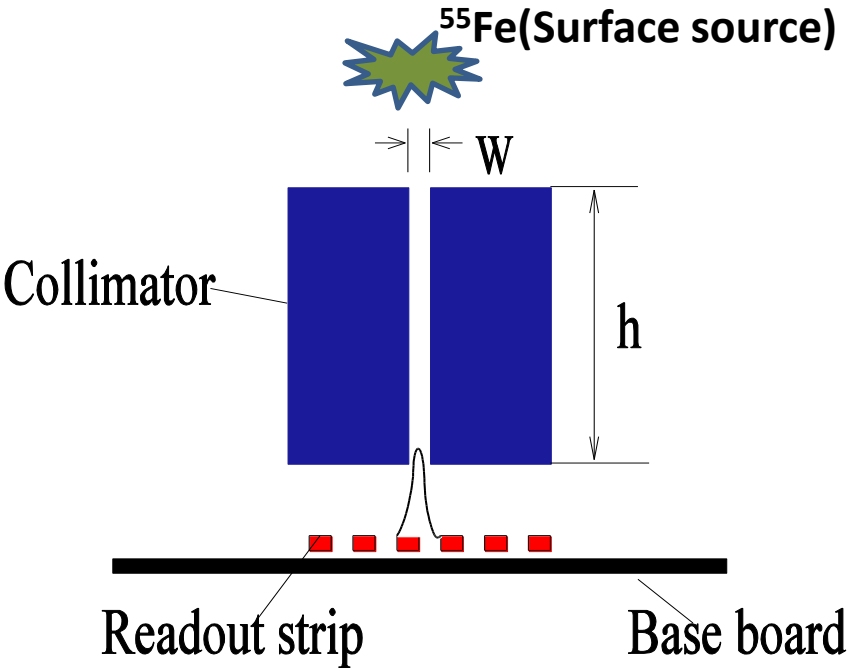


3, Very limited in electronics (16 channels);



It is natural to use method 1. But...

A practical method



$$\sigma_{tot}^2 = \sigma_{GEM}^2 + c_1 \sigma_{Geometry}^2$$

when $w \sim \sigma_{GEM}$

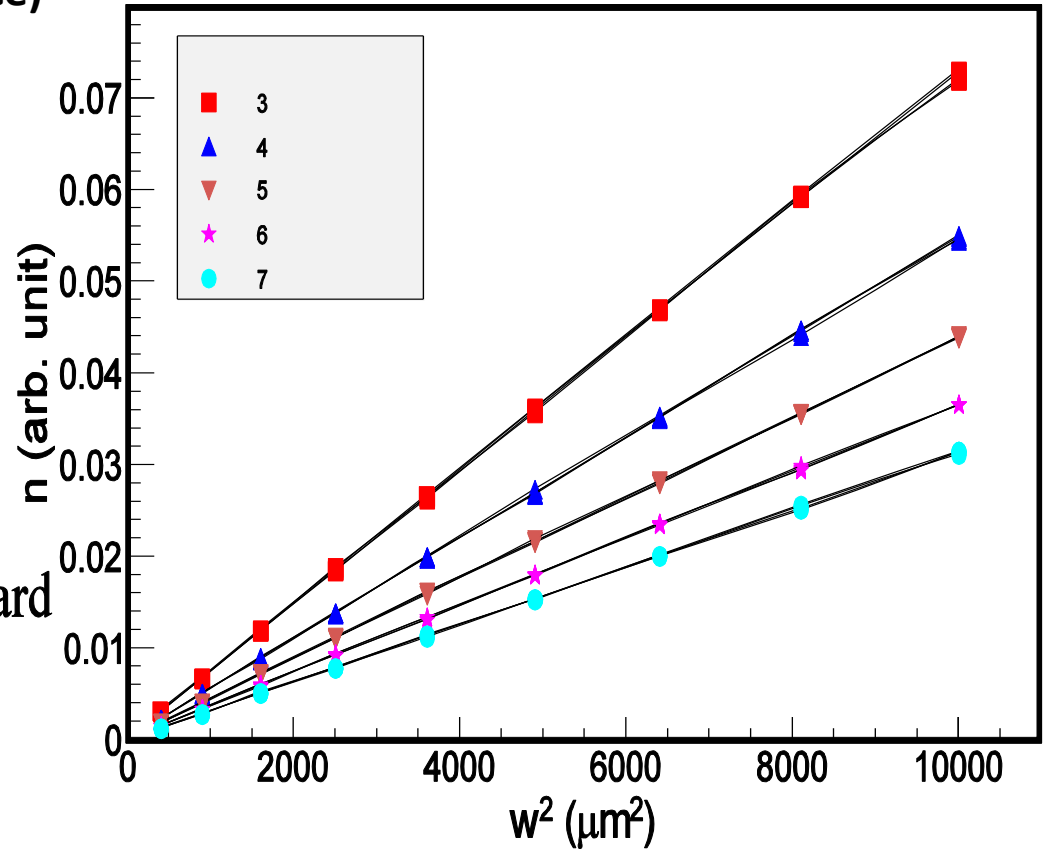
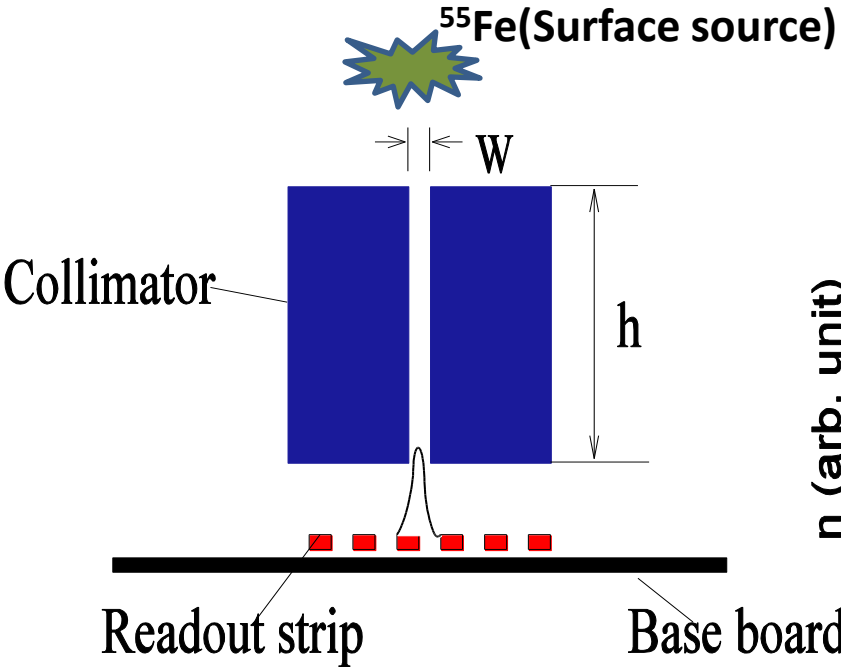
$$\sigma_{Geometry} = c_2 w$$

$$\sigma_{tot}^2 = \sigma_{GEM}^2 + c_0 w^2$$

But, the slit width can NOT be measured precisely.

Luckily:

A practical method (Continue)



$$n = c_2 w^2$$

therein, n means the counting rate

$$\sigma_{tot}^2 = \sigma_{GEM}^2 + c_0 n$$

Unit:mm

Simulation Results(1-D)

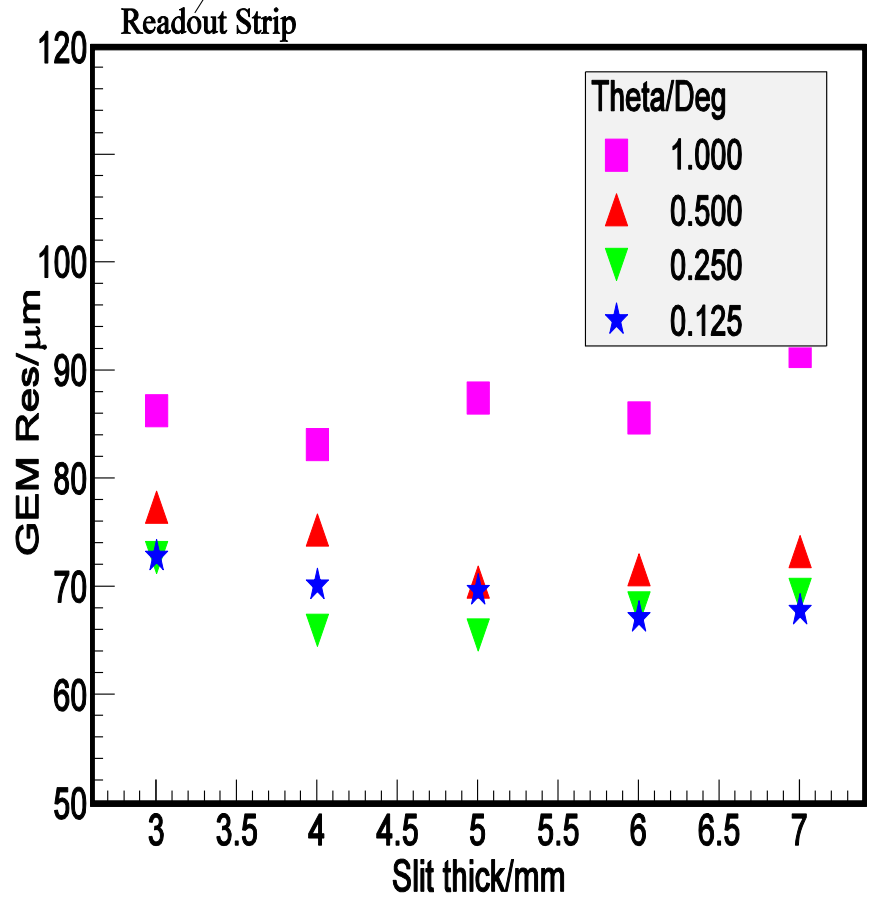
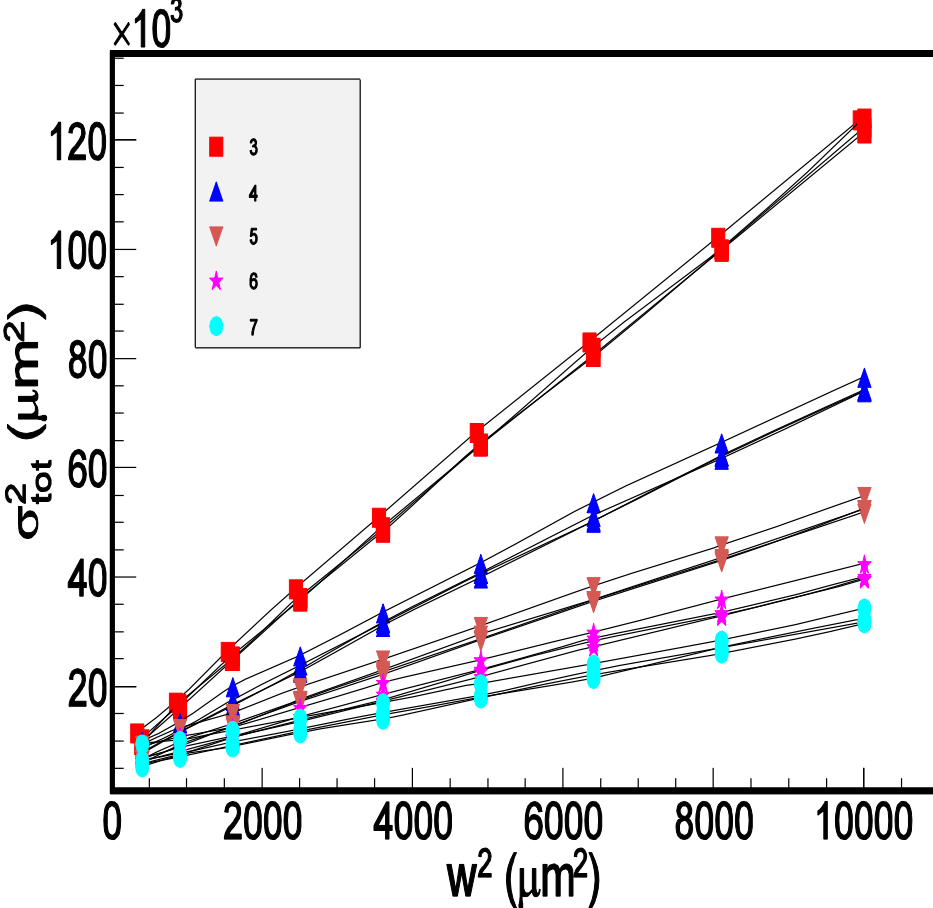
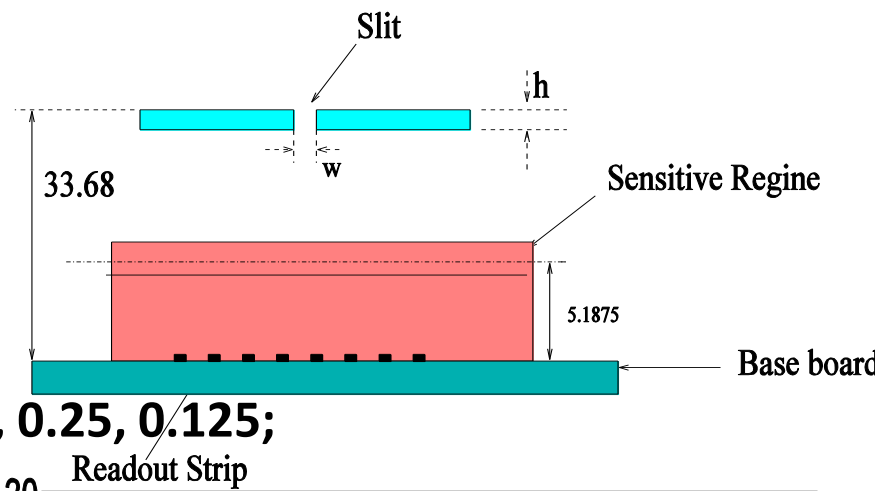
Simulation conditions:

GEM spatial resolution: 70 μm ;

Slit thickness(mm): 3, 4, 5, 6, 7;

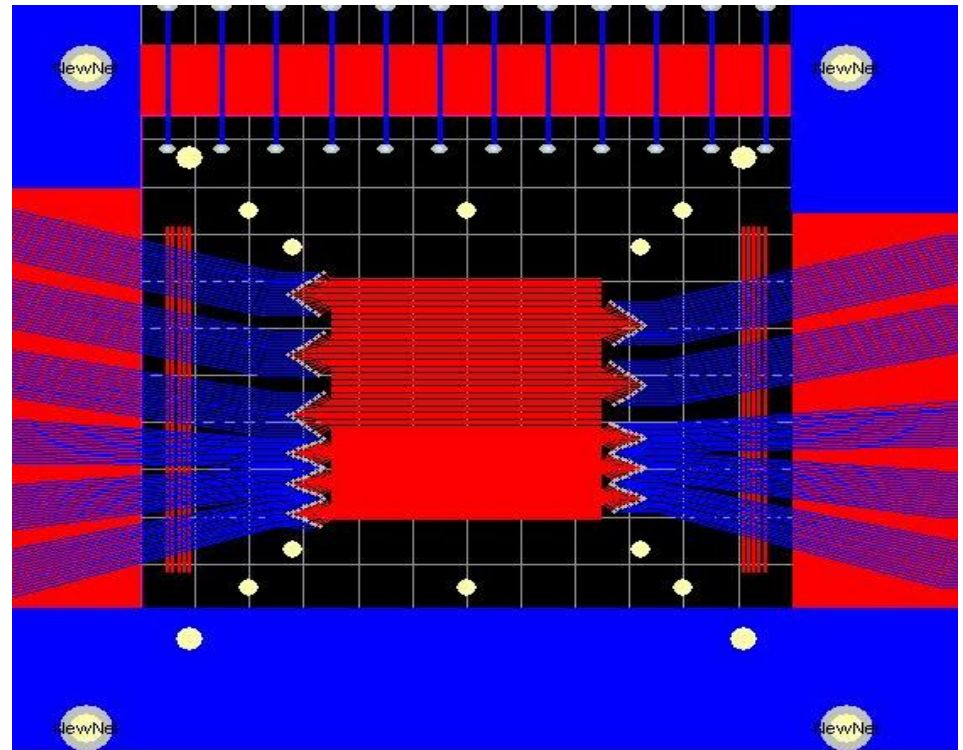
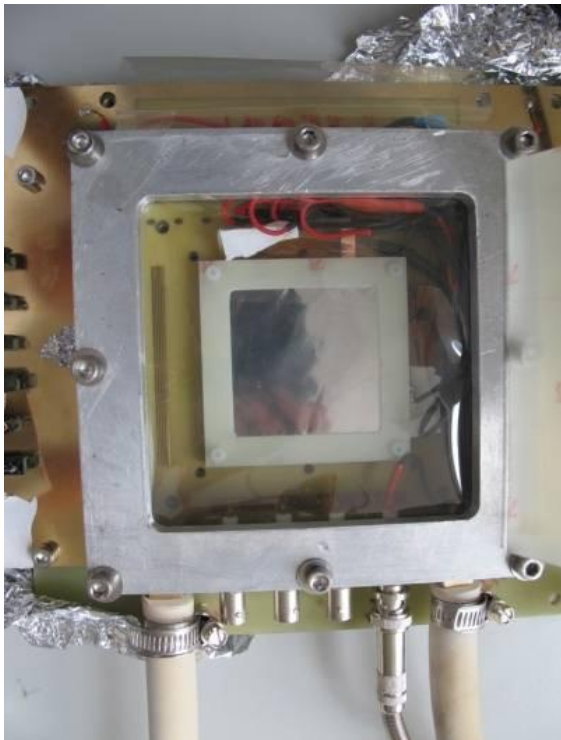
Slit width(μm):20,30... 100;

The angle(slit with readout strip, deg):1.0, 0.5, 0.25, 0.125;

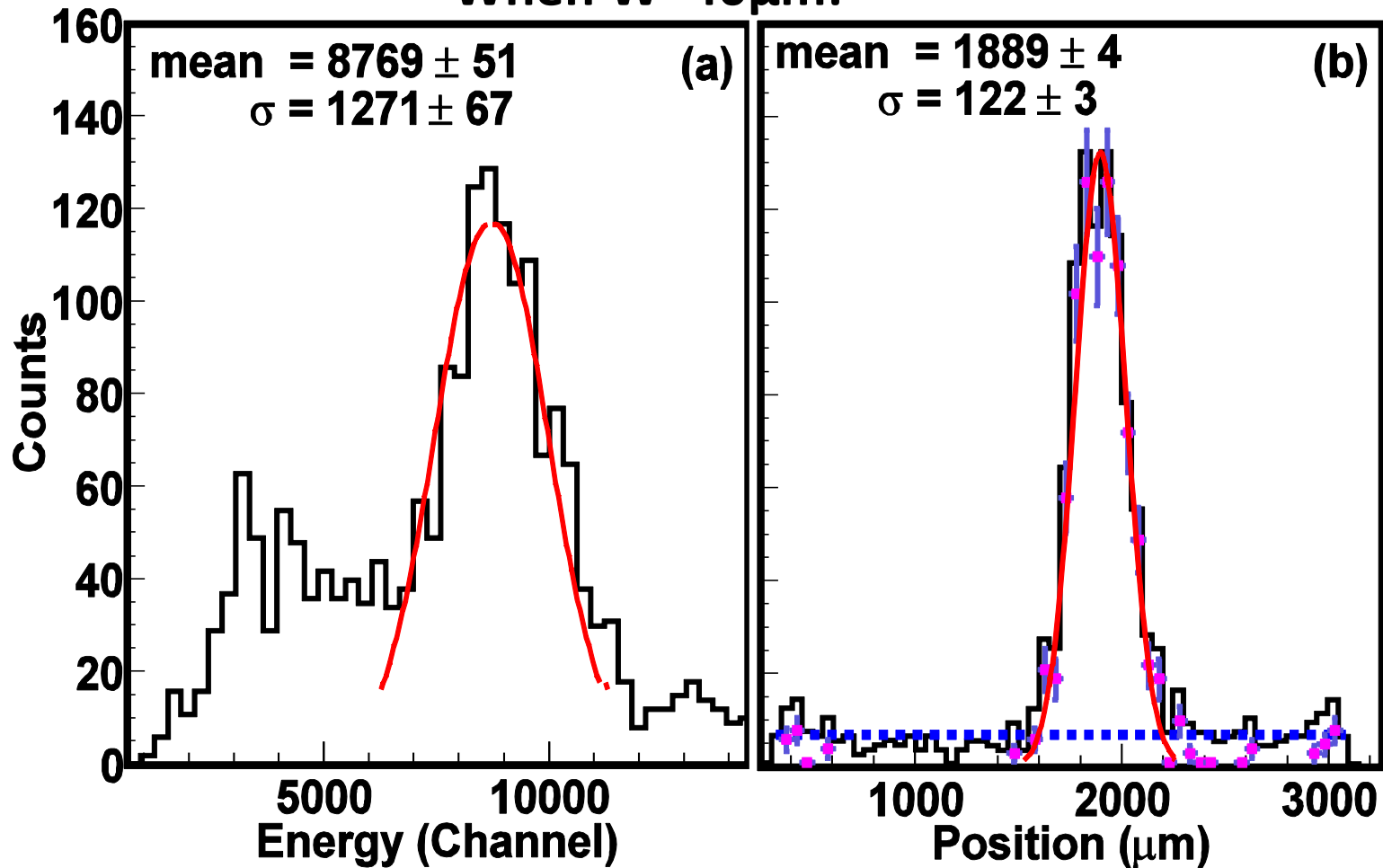


Experimental result

- 1-Dimension Readout
- Readout strip: $D=200\mu\text{m}$ $400\mu\text{m}$;



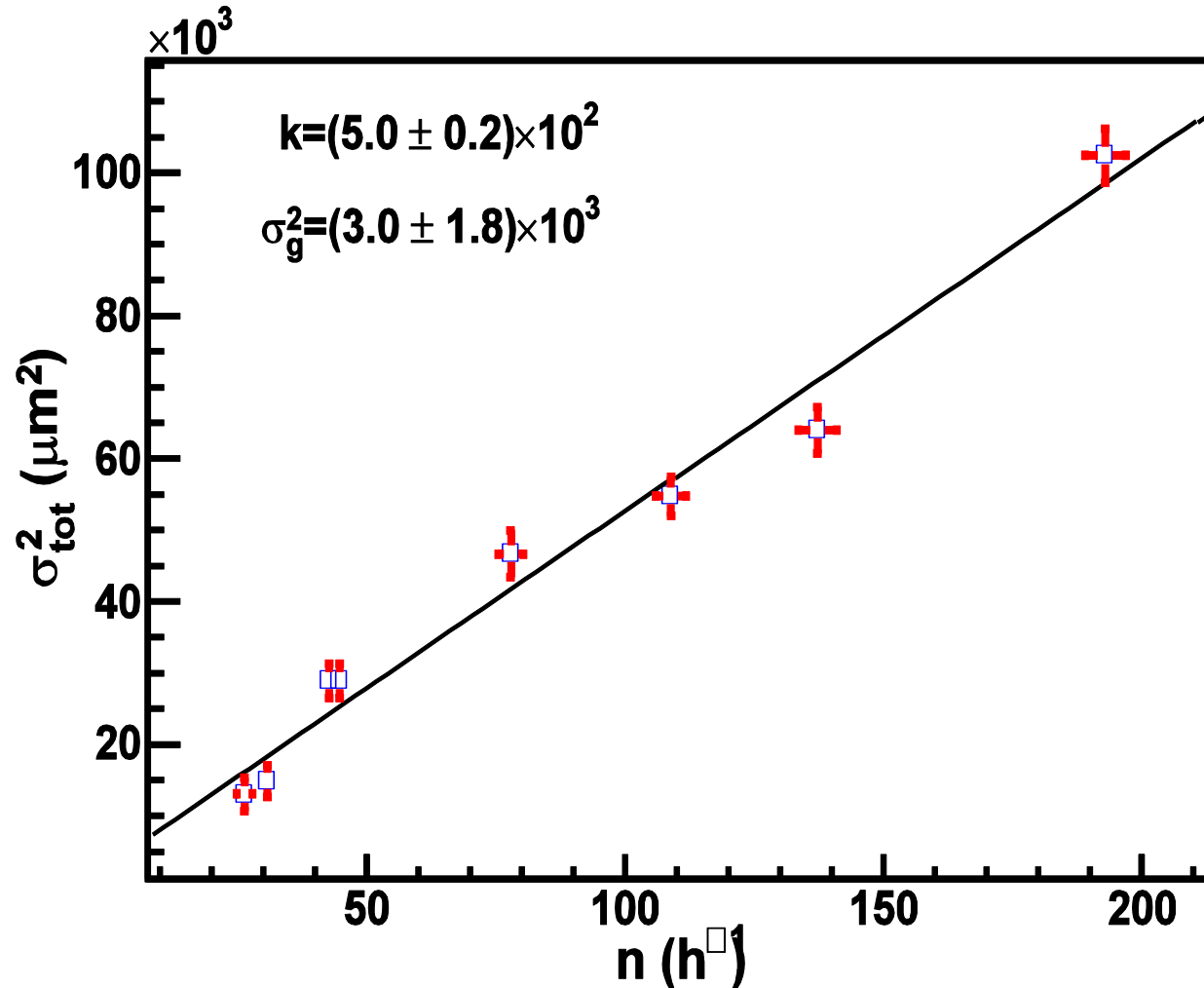
When $W \approx 40 \mu\text{m}$:



- 1, (a): get the events from main peak($\text{mean} \pm 2\sigma$), covered with the red line;
- 2, (b): calculate the position by the centre-of-gravity method; subtract the background(under the blue dotted line), then fit it with gaus-func;

3, $\text{ratio} = \frac{S}{T}$, Therein: S-the area of main peak; T-the testing time

The Test result(1-D, 200 μm readout strip)



$$\Delta n = \sqrt{\frac{n}{T}};$$

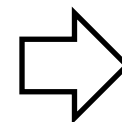
$$\Delta(\sigma_{\text{tot}}^2) = \Delta(\sigma_{\text{fit}}^2)$$

$$+ \Delta(\sigma_{\text{non-parallel}}^2)$$

(1), When $w \approx 40, 50, 60, 70, 80 \mu\text{m}$,
with the ratio as the x axis, with the σ_{tot}^2 as the y axis.

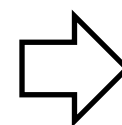
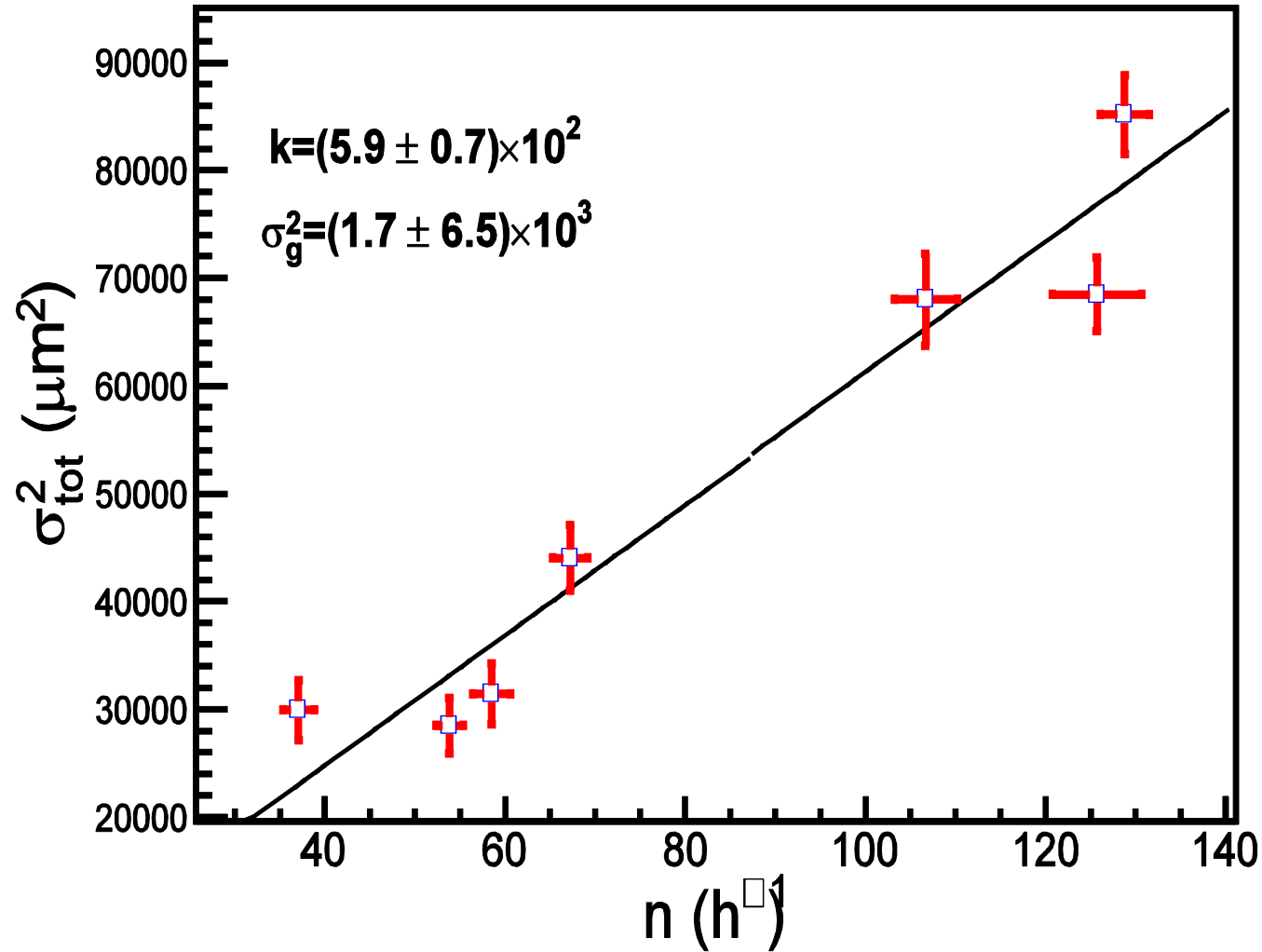
(2), Fit the graph with line-func, we can get

$$\sigma_{\text{tot}}^2 = 3.0 \times 10^3 + 5.0 \times 10^2 n$$



$$\sigma_{\text{GEM}} = 56 \pm 15 \mu\text{m}$$

The Test result(1-D, 400 μm readout strip)



$$\sigma_{\text{GEM}} = 41 \pm 79 \mu\text{m}$$

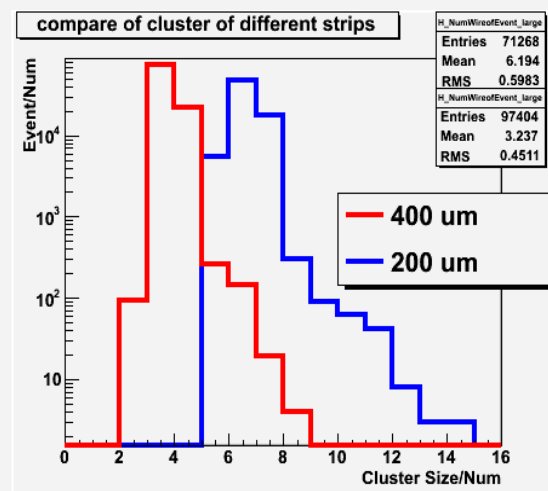
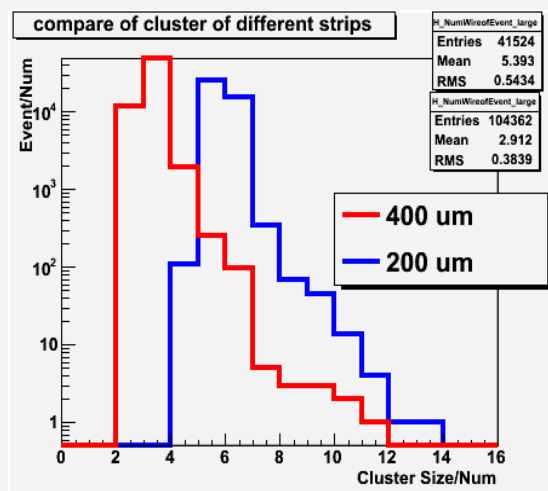
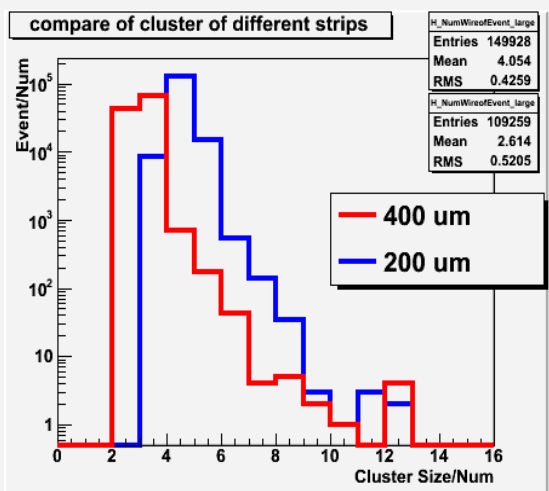
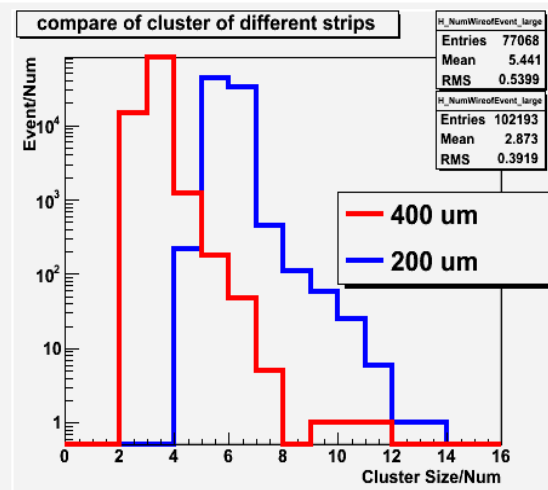
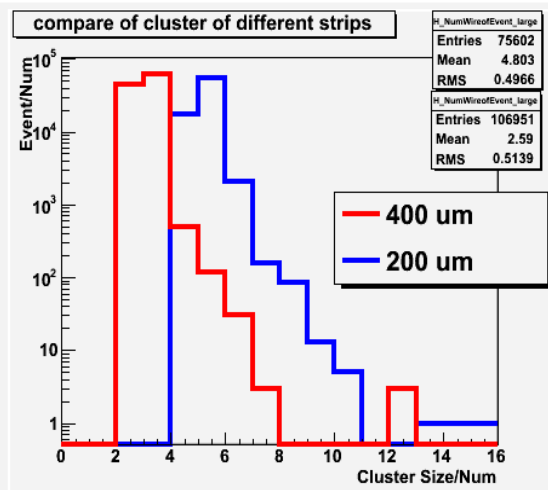
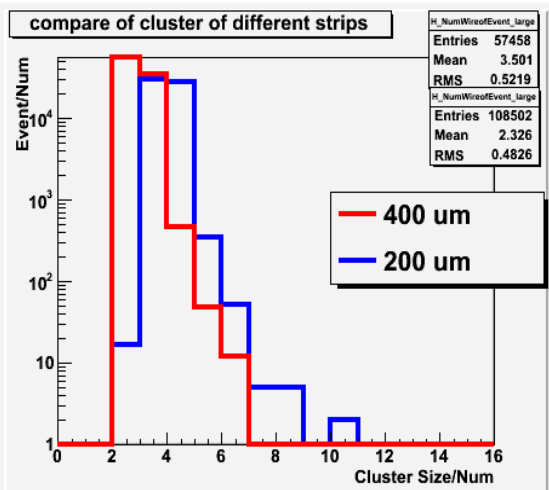
Cluster size of signal of main peak

- HV

1
7
1
0

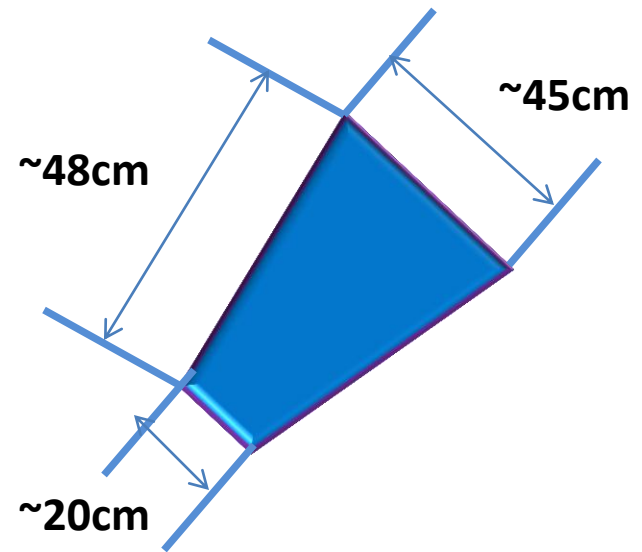
1
7
5
0

Ar 75 80 85



Near Future Plans

- ◆ **Further test:**
 - Position resolution for 2-D detector;
 - Simulation with Garfield;
 - Time resolution;
- ◆ **A prototype for SoLID**
- ◆ **APV electronics (1024)**
Asic-based electronics
- ◆ **Developpe the new DAQ**



Summary

- ◆ GEM-Detector prototype test is ongoing in our lab;
- ◆ A new method to evaluate the GEM spatial resolution:
 - 1) For 1-D and $W_{\text{readout}}=200\mu\text{m}$, $\sigma_{\text{gem}}=56\pm 15\mu\text{m}(1\sigma)$;
 - 2) Global performance tested for the prototype ;
Consistent with literature report
- ◆ Next step is to build a prototype for SoLID with new electronics and DAQ;

Looking forward to the arrival of the GEM foil and the APV electronics

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Thanks!

